## Single-Cell Protector for Li-lon Batteries

Check for Samples: bq294602, bq294604

## FEATURES

- Single-Cell Monitor for Secondary Protection
- Fixed Programmable Delay Timer
- Fixed OVP Threshold
- bq294602 $=4.35 \mathrm{~V}$ with 4 -s Delay Timer
- bq294604 $=4.35 \mathrm{~V}$ with 6.5 -s Delay Timer
- bq294622 $=4.45 \mathrm{~V}$ with 4-s Delay Timer
- bq294624 $=4.45 \mathrm{~V}$ with 6.5 -s Delay Timer
- bq294682 = 4.225 V with 4-s Delay Timer
- bq294684 = 4.225 V with 6.5-s Delay Timer
- High-Accuracy Overvoltage Protection: $\pm 10 \mathrm{mV}$
- Low Power Consumption $\mathrm{I}_{\mathrm{CC}} \approx 1 \mu \mathrm{~A}$ ( $\mathrm{V}_{\mathrm{CElL}(\mathrm{all})}$ < $\mathrm{V}_{\text {Protect }}$ )
- Low leakage current per cell input < 100 nA
- Small package footprint
- 6-pin SON


## APPLICATIONS

- $2^{\text {nd }}$-Level Protection in Li-lon Battery Packs in:
- Tablets
- Slates
- Portable Equipment and Instrumentation


## DESCRIPTION

The bq2946xy family of products is a secondary level voltage monitor and protector for Li-lon battery pack systems. The cell is monitored for over voltage condition and triggers an internal counter once the OVP threshold is exceeded and after a fixed set delay the out is transitioned to a high level. The output is reset (goes low) if the cell voltage drops below the set threshold minus the hysteresis.


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

| ORDERING INFORMATION ${ }^{(1)}$ |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{T}_{\text {A }}$ | PART NUMBER | PACKAGE | PACKAGE DESIGNATOR | OVP (V) | DELAY TIME (S) | TAPE AND REEL (LARGE) | TAPE AND REEL (SMALL) |
| $\begin{gathered} -40^{\circ} \mathrm{C} \text { to } \\ 110^{\circ} \mathrm{C} \end{gathered}$ | bq294602 | SON-6 | DRV | 4.35 | 4.0 | bq294602DRVR | bq294602DRVT |
|  | bq294604 |  |  | 4.35 | 6.5 | bq294604DRVR | bq294604DRVT |
|  | bq294622 ${ }^{(2)}$ |  |  | 4.45 | 4.0 | bq294622DRVR | bq294622DRVT |
|  | bq294624 ${ }^{(2)}$ |  |  | 4.45 | 6.5 | bq294624DRVR | bq294624DRVT |
|  | bq294682 ${ }^{(2)}$ |  |  | 4.225 | 4.0 | bq294682DRVR | bq294682DRVT |
|  | bq294684 ${ }^{(2)}$ |  |  | 4.225 | 6.5 | bq294684DRVR | bq294684DRVT |

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder on ti.com (www.ti.com).
(2) Product Preview only

## THERMAL INFORMATION

| THERMAL METRIC ${ }^{(1)}$ |  | bq2946xy | UNITS |
| :---: | :---: | :---: | :---: |
|  |  | SON |  |
|  |  | 6 PINS |  |
| $\theta_{\mathrm{JA}}$ | Junction-to-ambient thermal resistance | 186.4 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {JC(top) }}$ | Junction-to-case(top) thermal resistance | 90.4 |  |
| $\theta_{\mathrm{JB}}$ | Junction-to-board thermal resistance | 110.7 |  |
| $\Psi_{J T}$ | Junction-to-top characterization parameter | 96.7 |  |
| $\Psi_{\mathrm{JB}}$ | Junction-to-board characterization parameter | 90 |  |
| $\theta_{\mathrm{JC} \text { (bottom) }}$ | Junction-to-case(bottom) thermal resistance | n/a |  |

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

## PIN FUNCTIONS

| bq2946xy | Pin Name | Type I/O | Description |
| :---: | :---: | :---: | :--- |
| 1 | NC | - | No Connection |
| 2 | V1 | IA | Sense input for positive voltage of the cell |
| 3 | VSS | P | Electrically connected to IC ground and negative terminal of the <br> cell |
| 4 | VSS | Electrically connected to IC ground and negative terminal of the <br> cell |  |
| 5 | VDD | P | Power supply |
| 6 | PWRPAD | - | Output drive for external N-Channel FET <br> board for proper operation |
| Thermal Pad |  |  |  |

## PIN DETAILS

## Description

The method of overvoltage detection is comparing the cell voltage to an overvoltage protection threshold voltage $\mathrm{V}_{\text {ov }}$. Once the cell voltage exceeds the programmed fixed value $\mathrm{V}_{\mathrm{OV}}$, the delay timer circuit is activated. This delay ( $t_{\text {DELAY }}$ ) is fixed for 4 s for the bq294602 device. When these conditions are satisfied, the OUT terminal is transitioned to a high level. This output (OUT) is released to a low condition if the cell input (V1) is below the OVP threshold minus the $\mathrm{V}_{\mathrm{HYs}}$.


Figure 1. Timing for Overvoltage Sensing

## Sense Positive Input for V1

This is an input to sense single battery cell voltage. A series resistor and a capacitor across the cell is required for noise filtering and stable voltage monitoring.

## Output Drive, OUT

The gate of an external N -Channel MOSFET is connected to this terminal. This output transitions to a high level when an overvoltage condition is detected and after the programmed delay timer. The out will reset to a low level if the cell voltage falls below the $\mathrm{V}_{\mathrm{Ov}}$ threshold before the fixed delay timer expires.

## Supply Input, VDD

This terminal is the unregulated input power source for the IC. A series resistor is connected to limit the current, and a capacitor is connected to ground for noise filtering.

## Thermal Pad, PWRPAD

For correct operation, the power pad (PWRPAD) is connected to the $\mathrm{V}_{\mathrm{SS}}$ terminal on the printed circuit board.

## FUNCTIONAL BLOCK DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Over operating free-air temperature range (unless otherwise noted) ${ }^{(1)}$

| PARAMETER | CONDITION | VALUE/UNIT |
| :--- | :---: | :---: |
| Supply voltage range | VDD-VSS | -0.3 to 30 V |
| Input voltage range | V1-VSS | -0.3 to 8 V |
| Output voltage range | OUT-VSS | -0.3 to 30 V |
| Continuous total power dissipation, $\mathrm{P}_{\text {TOT }}$ |  | See package dissipation rating. |
| Functional temperature |  | -65 to $110^{\circ} \mathrm{C}$ |
| Storage temperature range, $\mathrm{T}_{\text {STG }}$ |  | -65 to $150^{\circ} \mathrm{C}$ |
| Lead temperature (soldering, 10 s ), $\mathrm{T}_{\text {SOLDER }}$ |  | $300^{\circ} \mathrm{C}$ |

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## RECOMMENDED OPERATING CONDITIONS

Over operating free-air temperature range (unless otherwise noted)

| PARAMETER | MIN | NOM | MAX | UNIT |
| :--- | :---: | :---: | :---: | :---: |
| Supply voltage, DD $^{(1)}$ | 3 |  | 8 |  |
| Input voltage range | V1-VSS | 0 |  | 5 |
| Operating ambient temperature range, TA | -40 |  | 110 | $V^{\circ}$ |

[^0]
## DC CHARACTERISTICS

Typical values stated where $T_{A}=25^{\circ} \mathrm{C}$ and $\mathrm{VDD}=4 \mathrm{~V}$, MIN/MAX values stated where $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $110^{\circ} \mathrm{C}$ and $\mathrm{V}_{\mathrm{DD}}=4 \mathrm{~V}$ (unless otherwise noted).

| Test | Symbol | Parameter | Condition | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Voltage Protection Threshold VCx |  |  |  |  |  |  |  |
| 1.0 | Vov | $\mathrm{V}_{\text {(PROTECT) }}$ Overvoltage Detection | bq294602, fixed delay $4 \mathrm{~s}, \mathrm{~V} 1>\mathrm{V}_{\text {OV }}$ |  | 4.35 |  | V |
| 1.1 |  |  | bq294604, fixed delay $6.5 \mathrm{~s}, \mathrm{~V} 1>\mathrm{V}_{\text {OV }}$ |  | 4.35 |  | V |
| 1.2 |  |  | bq294622, fixed delay $4 \mathrm{~s}, \mathrm{~V} 1>\mathrm{V}_{\text {OV }}{ }^{(1)}$ |  | 4.45 |  | V |
| 1.3 |  |  | bq294624, fixed delay $6.5 \mathrm{~s}, \mathrm{~V} 1>\mathrm{V}_{\mathrm{OV}}{ }^{(1)}$ |  | 4.45 |  | V |
| 1.4 |  |  | bq294682, fixed delay $4 \mathrm{~s}, \mathrm{~V} 1>\mathrm{V}_{\text {OV }}{ }^{(1)}$ |  | 4.225 |  | V |
| 1.5 |  |  | bq294684, fixed delay $6.5 \mathrm{~s}, \mathrm{~V} 1>\mathrm{V}_{\mathrm{OV}}{ }^{(1)}$ |  | 4.225 |  | V |
| 1.6 | $\mathrm{V}_{\mathrm{HYS}}$ | Overvoltage Detection Hysteresis |  | 250 | 300 | 400 | V |
| 1.7 | $\mathrm{V}_{\text {OA }}$ | OV Detection Accuracy | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | -10 |  | 10 | mV |
| 1.8 | $\mathrm{V}_{\text {OA -drift }}$ | OV Detection Accuracy due to Temperature | $\begin{aligned} & \mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C} \\ & \mathrm{~T}_{\mathrm{A}}=0^{\circ} \mathrm{C} \\ & \mathrm{~T}_{\mathrm{A}}=60^{\circ} \mathrm{C} \\ & \mathrm{~T}_{\mathrm{A}}=110^{\circ} \mathrm{C} \end{aligned}$ | $\begin{aligned} & \hline-40 \\ & -20 \\ & -24 \\ & -54 \\ & \hline \end{aligned}$ |  | $\begin{aligned} & 44 \\ & 20 \\ & 24 \\ & 54 \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{mV} \\ & \mathrm{mV} \\ & \mathrm{mV} \\ & \mathrm{mV} \end{aligned}$ |
| Supp ly and Leakage Current |  |  |  |  |  |  |  |
| 1.9 | $I_{\text {cc }}$ | Supply Current | (V1-VSS) $=4.0 \mathrm{~V}$ (See Figure 9 for reference) |  | 1 | 2 | $\mu \mathrm{A}$ |
|  |  |  | (V1-VSS) $=2.8 \mathrm{~V}$ with $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $60^{\circ} \mathrm{C}$ |  |  | 1.25 |  |
| 1.10 | In | Input Current at V1 Pins | $\begin{aligned} & \text { Measured at } \mathrm{V} 1=4.0 \mathrm{~V} \\ & \text { (V1-VSS) }=4.0 \mathrm{~V} \\ & \mathrm{~T}_{\mathrm{A}}=0^{\circ} \mathrm{C} \text { to } 60^{\circ} \mathrm{C} \text { (See Figure } 9 \text { for reference.) } \end{aligned}$ | -0.1 |  | 0.1 | $\mu \mathrm{A}$ |
| Output Drive OUT |  |  |  |  |  |  |  |
| 1.11 | $\mathrm{V}_{\text {OUT }}$ | Output Drive Voltage | $\begin{aligned} & (\mathrm{V} 1-\mathrm{VSS})>\mathrm{V}_{\mathrm{OV}} \\ & \mathrm{~V}_{\mathrm{DD}}=\mathrm{V} 1, \mathrm{I}_{\mathrm{OH}}=100 \mu \mathrm{~A}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C} \text { to } 110^{\circ} \mathrm{C} \end{aligned}$ | 3.0 | $V_{D D}-0.3$ |  | V |
| 1.13 |  |  | $\begin{aligned} & (\mathrm{V} 1-\mathrm{VSS})<\mathrm{V}_{\mathrm{OV},}, \mathrm{I}_{\mathrm{OL}}=100 \mu \mathrm{~A}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \\ & \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C} \text { to } 110^{\circ} \mathrm{C} \end{aligned}$ |  | 250 | 400 | mV |
| 1.14 | Iout(Short) | OUT Short Circuit Current | $\mathrm{OUT}=0 \mathrm{~V},(\mathrm{~V} 1-\mathrm{VSS})>\mathrm{V}$ OV |  | 1.5 | 3.0 | mA |
| 1.15 | $t_{R}$ | Output Rise Time | $\mathrm{CL}=1 \mathrm{nF}, \mathrm{V}_{\text {OH(OUT })}=0 \mathrm{~V}$ to $5 \mathrm{~V}^{(2)}$ |  | 5 |  | $\mu \mathrm{s}$ |
| 1.16 | $\mathrm{Z}_{0}$ | Output Impedance |  |  | 2 | 5 | k $\Omega$ |
| Fixed Delay Timer |  |  |  |  |  |  |  |
| 1.17 | $t_{\text {delay }}$ | Fault Detection Delay Time | Fixed Delay, bq2946x2 | 3.2 | 4 | 4.8 | s |
|  |  |  | Fixed Delay, bq2946x4 | 5.2 | 6.5 | 7.8 |  |
| 1.18 | $t_{\text {DELAY_CTM }}$ | Fault Detection Delay Time in Test Mode | Fixed delay (Internal settings) |  | 15 |  | ms |

(1) Product Preview only
(2) Specified by design. Not $100 \%$ tested in production.

## TYPICAL CHARACTERISTICS



Figure 2. $I_{C C}$ Current Consumption Versus Temperature


Figure 3. bq294602 Overvoltage Threshold (OVT) vs. Temp


Figure 4. Hysteresis $\mathrm{V}_{\mathrm{Hys}}$ Versus Temperature


Figure 5. Output Current Iout Versus Temperature

## APPLICATION INFORMATION



Figure 6. Application Configuration
NOTE
Connect VSS (Pins 3 and 4) externally to the CELL- terminal.
Changes to the ranges stated in Table 1 will impact the accuracy of the cell measurements. Figure 6 shows each external component.

Table 1. Parameters

| PARAMETER | External <br> Component | MIN | NOM | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Voltage monitor filter <br> resistance | RIN | 900 | 1000 | 1100 | $\Omega$ |
| Voltage monitor filter <br> capacitance | CIN | 0.01 | 0.1 |  | $\mu \mathrm{~F}$ |
| Supply voltage filter <br> resistance | RVD | 100 |  | 1 K | $\Omega$ |
| Supply voltage filter <br> capacitance | CVD |  | 0.1 | $\mu \mathrm{~F}$ |  |

## APPLICATION SCHEMATIC



Figure 7. 1-Cell Configuration with Fixed Delay

## NOTE

Connect VSS (Pins 3 and 4) externally to the CELL- terminal.

## CUSTOMER TEST MODE

Customer Test Mode (CTM) helps to reduce test time for checking the overvoltage delay timer parameter once the circuit is implemented in the battery pack. To enter CTM, VDD should be set to at least 10 V higher than V 1 (see Figure 8). The delay timer is greater than 10 ms , but considerably shorter than the timer delay in normal operation. To exit Customer Test Mode, remove the VDD to V1 voltage differential of 10 V so that the decrease in this value automatically causes an exit.

## CAUTION

Avoid exceeding any Absolute Maximum Voltages on any pins when placing the part into Customer Test Mode. Also avoid exceeding Absolute Maximum Voltage for the cell voltage (V1-VSS). Stressing the pins beyond the rated limits may cause permanent damage to the device.

Figure 8 shows the timing for the Customer Test Mode.


Figure 8. Timing for Customer Test Mode
Figure 9 shows the measurement for current consumption for the product for both VDD and Vx.


Figure 9. Configuration for IC Current Consumption Test

## REVISION HISTORY

Changes from Original (December 2011) to Revision A Page

- Added the bq294604 device into production. ..... 2
Changes from Original (February 2012) to Revision B Page
- Added a second $\mathrm{I}_{\mathrm{CC}}$ Test Condition ..... 5

InSTRUMENTS

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package Type | Package Drawing | Pins | Package Qty | Eco Plan ${ }^{(2)}$ | Lead/ Ball Finish | MSL Peak Temp ${ }^{(3)}$ | Samples <br> (Requires Login) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| BQ294602DRVR | ACTIVE | SON | DRV | 6 | 3000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR |  |
| BQ294602DRVT | ACTIVE | SON | DRV | 6 | 250 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR |  |
| BQ294604DRVR | ACTIVE | SON | DRV | 6 | 3000 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR |  |
| BQ294604DRVT | ACTIVE | SON | DRV | 6 | 250 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | CU NIPDAU | Level-2-260C-1 YEAR |  |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability formation and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
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${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
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## TAPE AND REEL INFORMATION

REEL DIMENSIONS


W1

TAPE AND REEL INFORMATION
*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> W1 <br> $(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| BQ294602DRVR | SON | DRV | 6 | 3000 | 330.0 | 12.4 | 2.2 | 2.2 | 1.1 | 8.0 | 12.0 | Q2 |
| BQ294602DRVT | SON | DRV | 6 | 250 | 180.0 | 12.4 | 2.2 | 2.2 | 1.1 | 8.0 | 12.0 | Q2 |
| BQ294604DRVR | SON | DRV | 6 | 3000 | 330.0 | 12.4 | 2.2 | 2.2 | 1.1 | 8.0 | 12.0 | Q2 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| BQ294602DRVR | SON | DRV | 6 | 3000 | 367.0 | 367.0 | 35.0 |
| BQ294602DRVT | SON | DRV | 6 | 250 | 210.0 | 185.0 | 35.0 |
| BQ294604DRVR | SON | DRV | 6 | 3000 | 367.0 | 367.0 | 35.0 |

[^1]
## DRV (S-PWSON-N6)

## PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION
This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.
The exposed thermal pad dimensions for this package are shown in the following illustration.
(CO.30)
PIN 1 IDENTIFICATION


Bottom View

Exposed Thermal Pad Dimensions

NOTE: A. All linear dimensions are in millimeters

DRV (S-PWSON-N6)
PLASTIC SMALL OUTLINE NO-LEAD


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate designs.
D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com [http://www.ti.com](http://www.ti.com).
E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
F. Customers should contact their board fabrication site for solder mask tolerances.

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## Applications

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[^0]:    (1) See APPLICATION SCHEMATIC.

[^1]:    NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
    B. This drawing is subject to change without notice.
    C. Small Outline No-Lead (SON) package configuration.

    D The package thermal pad must be soldered to the board for thermal and mechanical performance.
    See the Product Data Sheet for details regarding the exposed thermal pad dimensions.

